<ul> <li>State-of-the-Art BiCMOS Design Significantly Reduces I<sub>CCZ</sub></li> </ul>	D OR N PACKAGE (TOP VIEW)
<ul> <li>3-State Outputs Drive Bus Lines or Buffer-Memory Address Registers</li> </ul>	
<ul> <li>ESD Protection Exceeds 2000 V Per MIL-STD-883 Method 3015</li> </ul>	1A    2 13    4OE 1Y    3 12    4A 2OE    4 11    4Y
<ul> <li>High-Impedance State During Power Up and Power Down</li> </ul>	$2OE \begin{bmatrix} 4 \\ 10 \end{bmatrix} 47$ $2A \begin{bmatrix} 5 \\ 10 \end{bmatrix} 3OE$ $2Y \begin{bmatrix} 6 \\ 9 \end{bmatrix} 3A$
<ul> <li>Package Options Include Plastic Small-Outline (D) and Standard Plastic 300-mil DIPs (N)</li> </ul>	GND [7 8] 3Y

### description

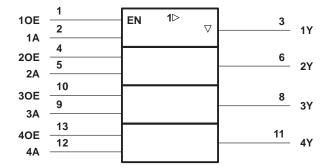
The SN64BCT126A bus buffer features independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable (OE) input is low.

The SN64BCT126A is characterized for operation from – 40°C to 85°C and 0°C to 70°C.

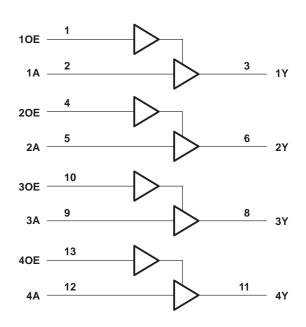
(each buffer)							
INPU	JTS	OUTPUT					
OE	Α	Y					
Н	Н	Н					
н	L	L					
L	Х	Z					

**FUNCTION TABLE** 

## logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



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## SN64BCT126A QUADRUPLE BUS BUFFER GATE WITH 3-STATE OUTPUTS

SCBS051C - AUGUST 1990 - REVISED JULY 1998

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the disabled or power-off state, VO	0.5 V to 5.5 V
Voltage range applied to any output in the high state, VO	-0.5 V to V <sub>CC</sub>
Current into any output in the low state, I <sub>O</sub>	128 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): D package	127°C/W
N package	
Storage temperature range, T <sub>stg</sub> –6	5°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative voltage rating may be exceeded if the input clamp current rating is observed.

2. The package thermal impedance is calculated in acordane with JESD 51, except for through-hole packages, which use a trace length of zero.

### recommended operating conditions (see Note 3)

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
Iк	Input clamp current			-18	mA
IOH	High-level output current			-15	mA
I <sub>OL</sub>	Low-level output current			64	mA
Т <sub>А</sub>	Operating free-air temperature	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



# SN64BCT126A QUADRUPLE BUS BUFFER GATE WITH 3-STATE OUTPUTS SCBS051C - AUGUST 1990 - REVISED JULY 1998

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TES	MIN	түр†	MAX	UNIT	
VIK	$V_{CC} = 4.5 V,$	Ij = -18 mA			-1.2	V
Vou		$I_{OH} = -3 \text{ mA}$	2.4	3.3		V
VOH	$V_{CC} = 4.5 V$	I <sub>OH</sub> = –15 mA	2	3.1		v
VOL	$V_{CC} = 4.5 V,$	I <sub>OH</sub> = 64 mA		0.42	0.55	V
IOZH	V <sub>CC</sub> = 5.5 V,	$V_{O} = 2.7 V$			50	μA
IOZL	V <sub>CC</sub> = 5.5 V,	$V_{O} = 0.5 V$			-50	μA
107	$V_{CC} = 0$ to 1.3 V (power up)	V <sub>O</sub> = 2.7 V or 0.5 V, OE at 2 V			±50	
IOZ	$V_{CC}$ = 1.3 V to 0 (power down)	0 = 2.7 v or 0.5 v, $0 = 2.7$			±50	μA
l	$V_{CC} = 0,$	$V_{I} = 7 V$			0.1	mA
ΙΗ	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			25	μA
١ <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			-20	μA
los‡	V <sub>CC</sub> = 5.5 V,	$V_{O} = 0$	-100		-225	mA
ICCL	$V_{CC} = 5.5 V$			35	51	mA
Іссн	$V_{CC} = 5.5 V$			21	33	mA
ICCZ	V <sub>CC</sub> = 5.5 V			5	10	mA
C <sub>i</sub>	V <sub>CC</sub> = 5 V,	$V_{I} = 2.5 \text{ V or } 0.5 \text{ V}$		4		pF
Co	V <sub>CC</sub> = 5 V,	V <sub>O</sub> = 2.5 V or 0.5 V		9		pF

<sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . <sup>‡</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

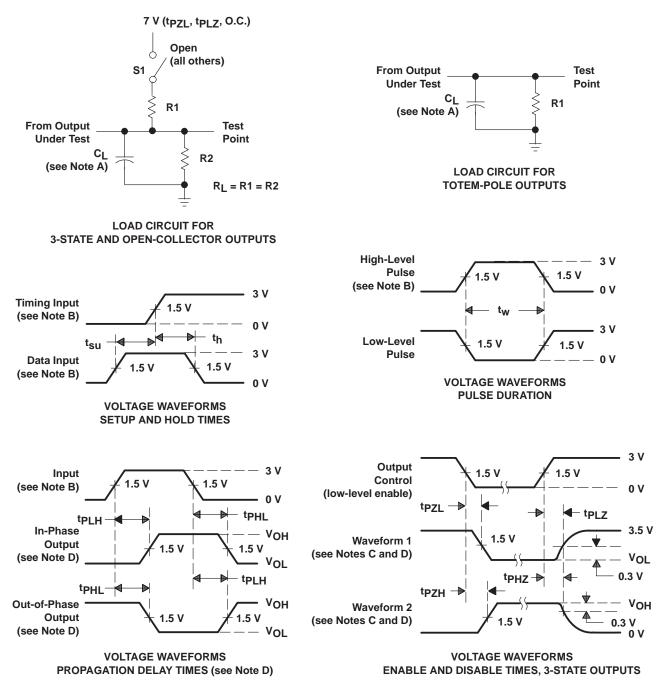
### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL R1	C = 5 V, = 50 pF = 500 Ω = 500 Ω	; <u>)</u> ,	CL R1 R2	= 50 pF = 500 Ω = 500 Ω	<u>)</u> , <u>)</u>		UNIT	
		(001101)		= 25°C	-)	T <sub>A</sub> = - to 8		T <sub>A</sub> = to 70			
					MIN	TYP	MAX	MIN	MAX	MIN	MAX
<sup>t</sup> PLH	А	Y	1.5	3.6	4.9	1.5	6.3	1.5	6.3	ns	
<sup>t</sup> PHL	A	I	2.7	5.3	6.9	2.7	7.7	2.7	7.4	115	
<sup>t</sup> PZH	OE	Y	2.6	4.8	6.4	2.6	7.9	2.6	7.9	ns	
<sup>t</sup> PZL	OE	I	3.7	6.4	8.3	3.7	10.5	3.7	10	115	
<sup>t</sup> PHZ	OE	Y	3.2	6.6	8.2	3.2	10	3.2	10	ns	
<sup>t</sup> PLZ	0L	I	3.4	6.5	8	3.4	12.3	3.4	10.7	115	



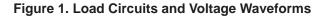
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### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, t<sub>f</sub> = t<sub>f</sub>  $\leq$  2.5 ns, duty cycle = 50%.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.
- E. When measuring propagation delay times of 3-state outputs, switch S1 is open.







21-Mar-2013

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
SN64BCT126AD	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126ADE4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126ADG4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126ADR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126ADRE4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126ADRG4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	6BCT126A	Samples
SN64BCT126AN	OBSOLETE	PDIP	N	14		TBD	Call TI	Call TI	-40 to 85	SN64BCT126AN	
SN64BCT126ANE4	ACTIVE	PDIP	Ν	14		TBD	Call TI	Call TI	-40 to 85		Samples
SN64BCT126ANSR	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	DCT126A	Samples
SN64BCT126ANSRE4	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	DCT126A	Samples
SN64BCT126ANSRG4	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	DCT126A	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.



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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

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TAPE AND REEL INFORMATION

#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN64BCT126ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN64BCT126ANSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1

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# PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN64BCT126ADR	SOIC	D	14	2500	367.0	367.0	38.0
SN64BCT126ANSR	SO	NS	14	2000	367.0	367.0	38.0

## N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
   E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



## MECHANICAL DATA

### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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